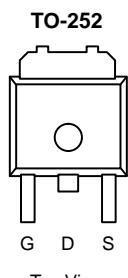


N-Channel 40-V (D-S) 175°C MOSFET

PRODUCT SUMMARY		
V_{DS} (V)	$r_{DS(on)}$ (Ω)	I_D (A)
40	0.025 @ $V_{GS} = 10$ V	25
	0.040 @ $V_{GS} = 4.5$ V	20

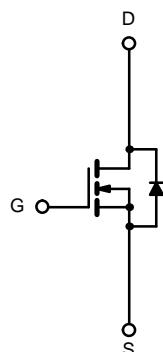
175°C Rated
Maximum Junction Temperature
TrenchFET®
Power MOSFETs



Drain Connected to Tab

Top View

Order Number:
SUD25N04-25



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current ($T_J = 175^\circ\text{C}$) ^b	I_D	25	
		15	
Pulsed Drain Current	I_{DM}	50	A
Continuous Source Current (Diode Conduction) ^b	I_S	50	
Avalanche Current	I_{AR}	25	
Repetitive Avalanche Energy (Duty Cycle $\leq 1\%$)	E_{AR}	31	mJ
Maximum Power Dissipation	P_D	33 ^b	W
		3 ^b	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 175	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Junction-to-Ambient ^b	R_{thJA}	20	25	°C/W
		40	50	
Junction-to-Case	R_{thJC}	3.7	4.5	

Notes

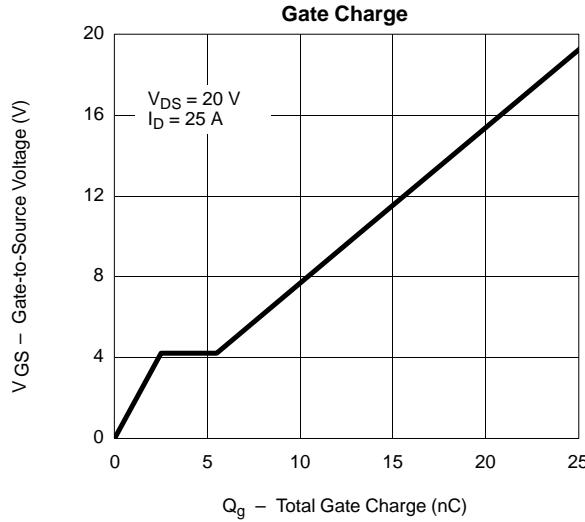
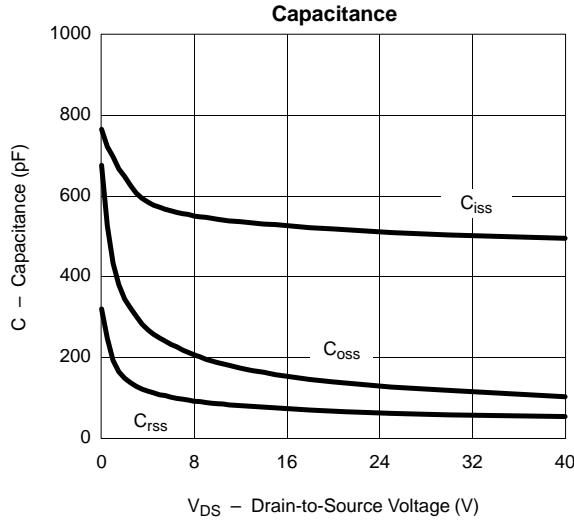
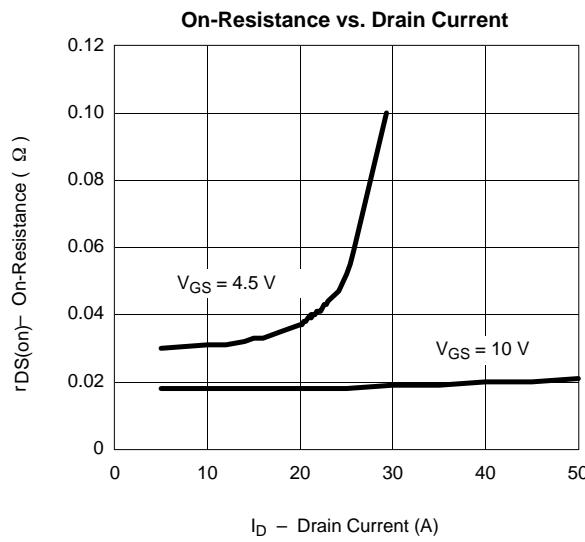
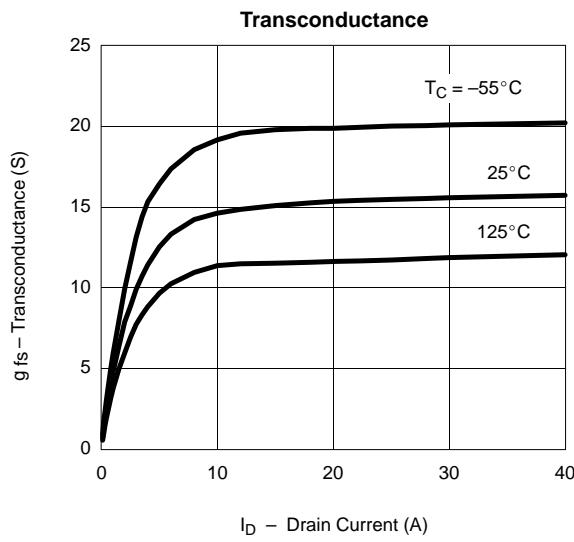
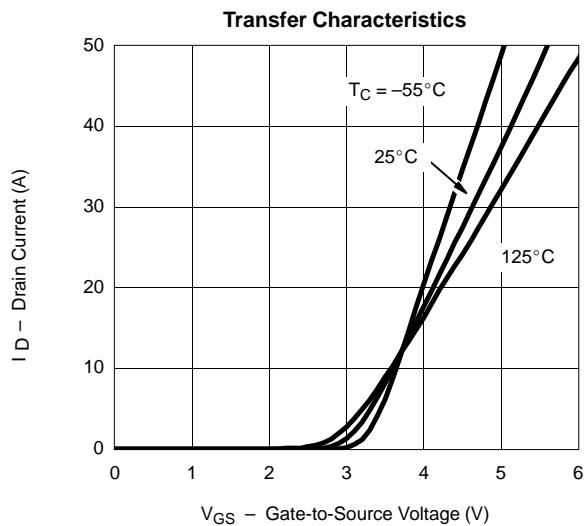
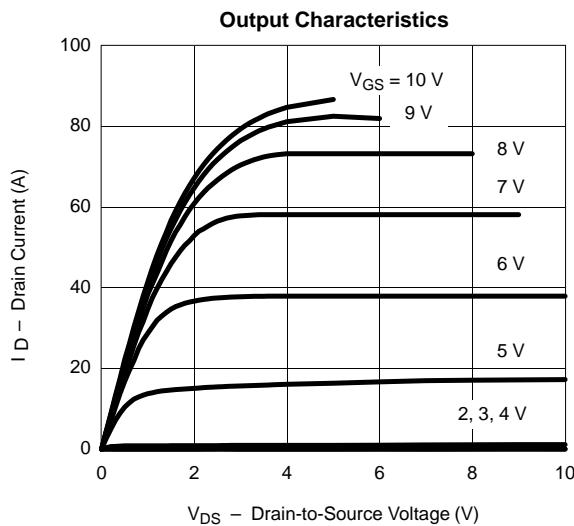
- a. Surface Mounted on 1" x1" FR4 Board.
- b. See SOA curve for voltage derating.

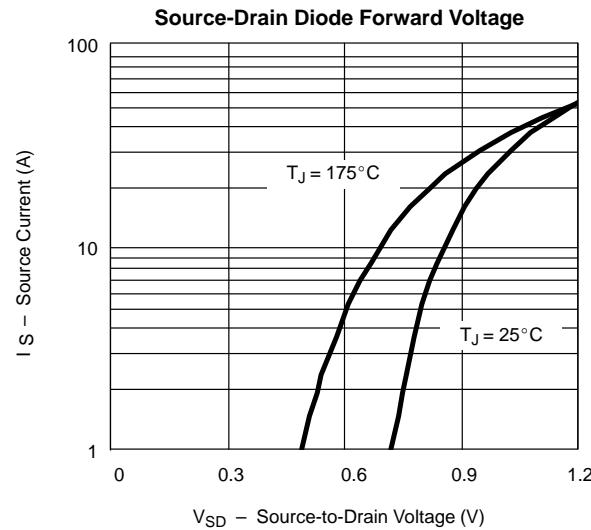
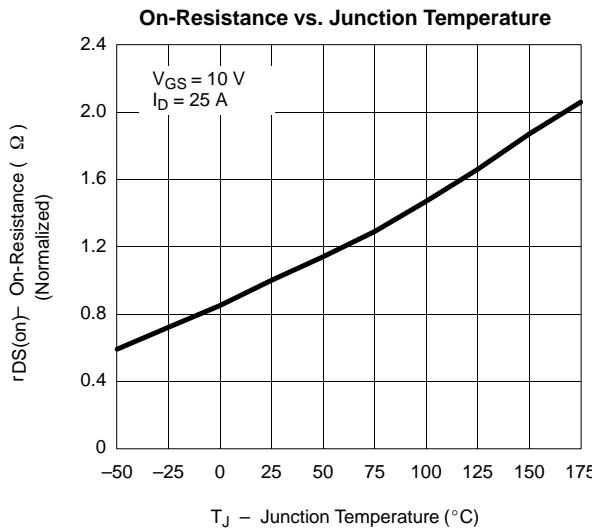
**SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)**

Parameter	Symbol	Test Condition	Min	Typ ^a	Max	Unit
Static						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	1.0	2.0	3.0	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0 \text{ V}, V_{\text{GS}} = \pm 20 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 40 \text{ V}, V_{\text{GS}} = 0 \text{ V}$			1	
		$V_{\text{DS}} = 40 \text{ V}, V_{\text{GS}} = 0 \text{ V}, T_J = 125^\circ\text{C}$			50	μA
		$V_{\text{DS}} = 40 \text{ V}, V_{\text{GS}} = 0 \text{ V}, T_J = 175^\circ\text{C}$			150	
On-State Drain Current ^b	$I_{\text{D}(\text{on})}$	$V_{\text{DS}} = 5 \text{ V}, V_{\text{GS}} = 10 \text{ V}$	50			A
Drain-Source On-State Resistance ^b	$r_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10 \text{ V}, I_D = 25 \text{ A}$		0.02	0.025	
		$V_{\text{GS}} = 10 \text{ V}, I_D = 25 \text{ A}, T_J = 125^\circ\text{C}$			0.040	Ω
		$V_{\text{GS}} = 10 \text{ V}, I_D = 25 \text{ A}, T_J = 175^\circ\text{C}$			0.053	
		$V_{\text{GS}} = 4.5 \text{ V}, I_D = 10 \text{ A}$		0.031	0.040	
Forward Transconductance ^b	g_{fs}	$V_{\text{DS}} = 15 \text{ V}, I_D = 25 \text{ A}$		15		S
Dynamic^a						
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0 \text{ V}, V_{\text{DS}} = 25 \text{ V}, F = 1 \text{ MHz}$		510		
Output Capacitance	C_{oss}			125		pF
Reverse Transfer Capacitance	C_{rss}			65		
Total Gate Charge ^c	Q_g	$V_{\text{DS}} = 20 \text{ V}, V_{\text{GS}} = 10 \text{ V}, I_D = 25 \text{ A}$		13	20	
Gate-Source Charge ^c	Q_{gs}			2.5		nC
Gate-Drain Charge ^c	Q_{gd}			3		
Turn-On Delay Time ^c	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 20 \text{ V}, R_L = 0.8 \Omega$ $I_D \approx 25 \text{ A}, V_{\text{GEN}} = 10 \text{ V}, R_G = 2.5 \Omega$		5	10	
Rise Time ^c	t_r			47	70	
Turn-Off Delay Time ^c	$t_{\text{d}(\text{off})}$			12	20	
Fall Time ^c	t_f			3	6	ns
Source-Drain Diode Ratings and Characteristic ($T_C = 25^\circ\text{C}$)						
Pulsed Current	I_{SM}			50		A
Diode Forward Voltage ^b	V_{SD}	$I_F = 25 \text{ A}, V_{\text{GS}} = 0 \text{ V}$		1.1	1.3	V
Source-Drain Reverse Recovery Time	t_{rr}	$I_F = 25 \text{ A}, \text{di/dt} = 100 \text{ A}/\mu\text{s}$		17	30	ns

Notes

- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.
- c. Independent of operating temperature.

TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)


TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)**THERMAL RATINGS**